

FIG. 1

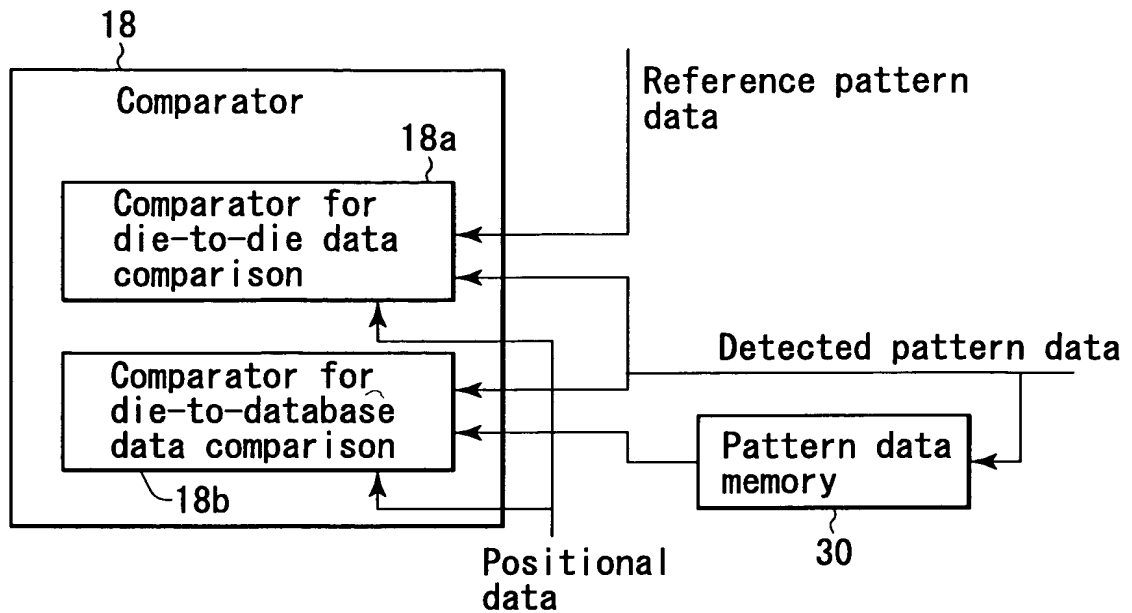


FIG. 2

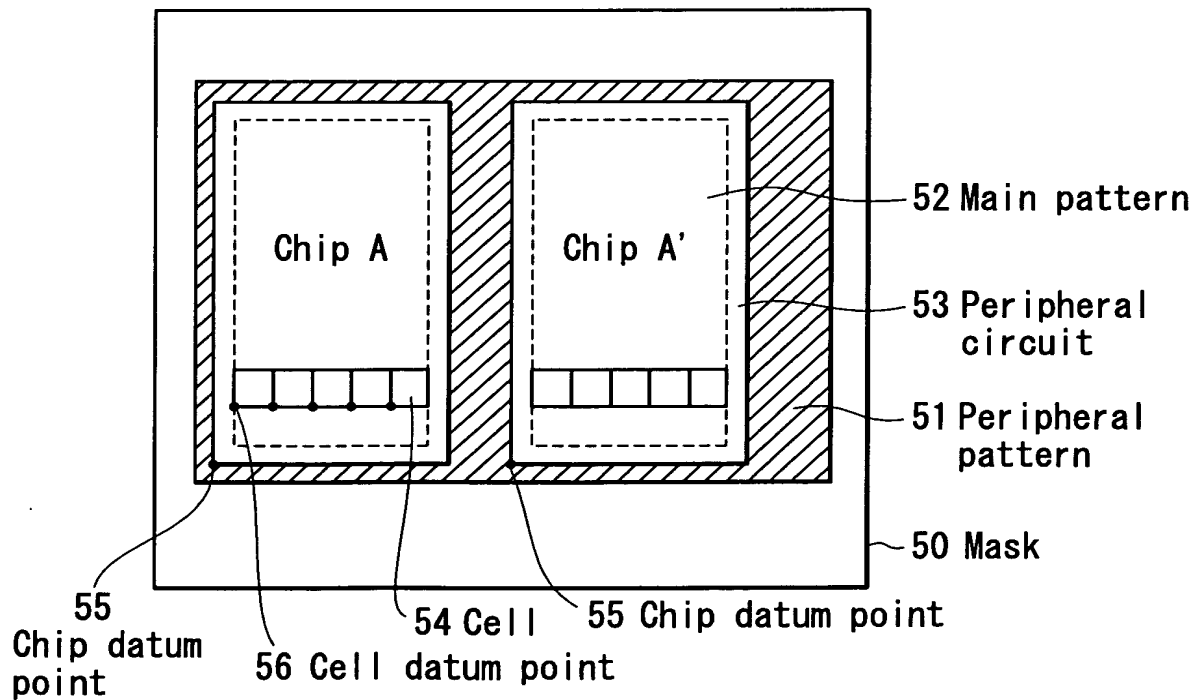


FIG. 3

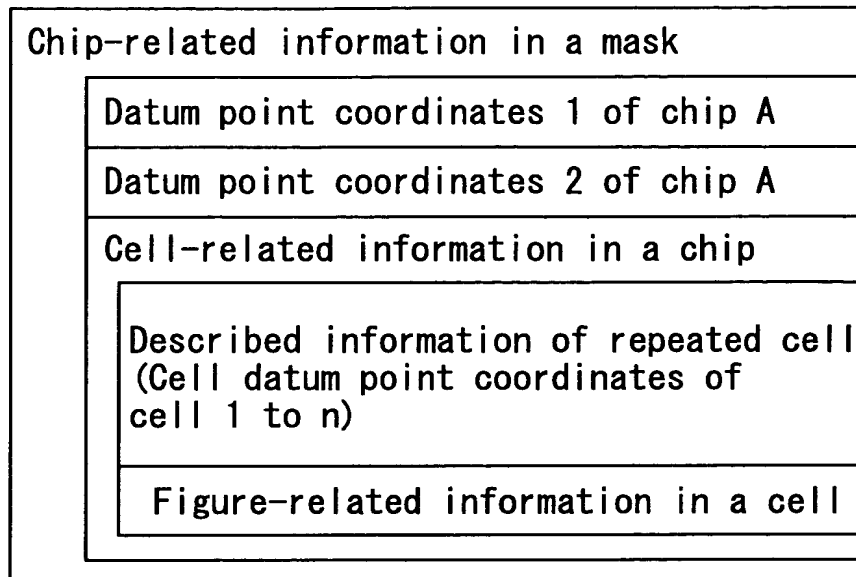


FIG. 4

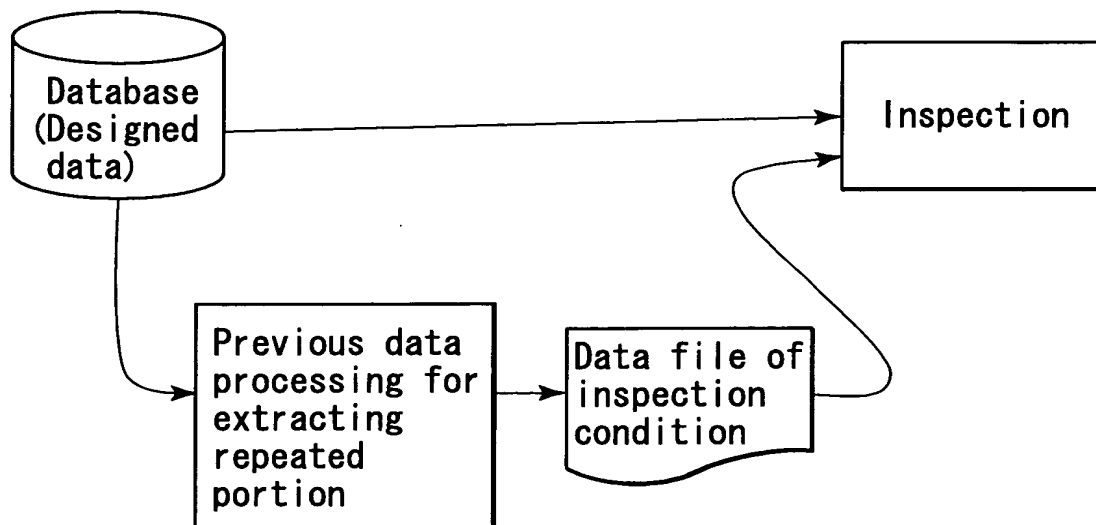


FIG. 5

Inspection data item:
Threshold level of defect or not
Discrimination condition a:
Discrimination condition b:
Discrimination condition c:

Illumination method of
transmitted/reflected light:
Magnification mode of optics in inspection
Alignment-related information
:::
Inspection mode of die-to-die combined
with die-to-database (ON/OFF)
Start point coordinates of die 1(x1,y1):
Finish point coordinates of die 1(x2,y2):
Start point coordinates of die 2(x3,y3):
Finish point coordinates of die 2(x4,y4):

FIG. 6

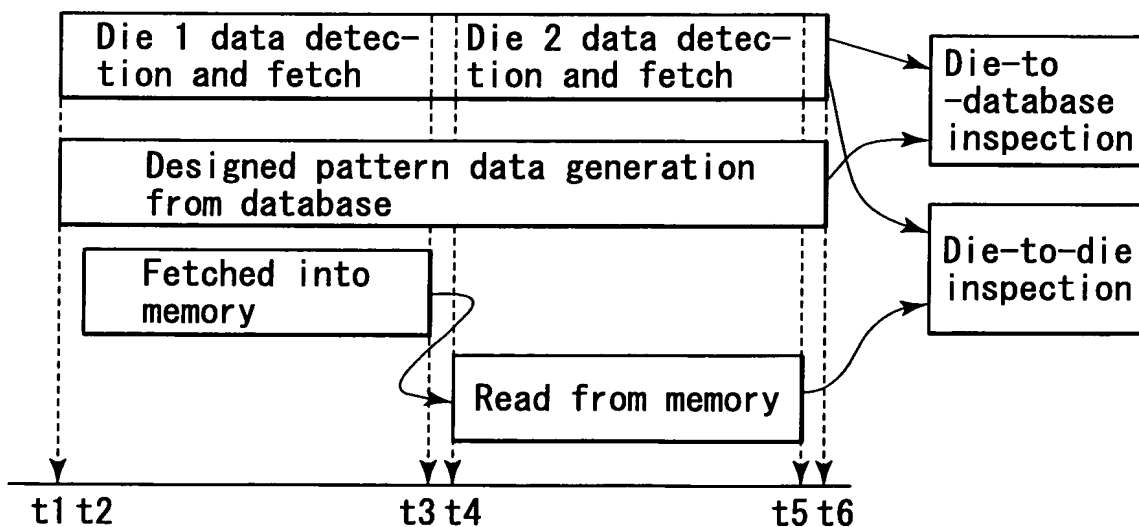


FIG. 7

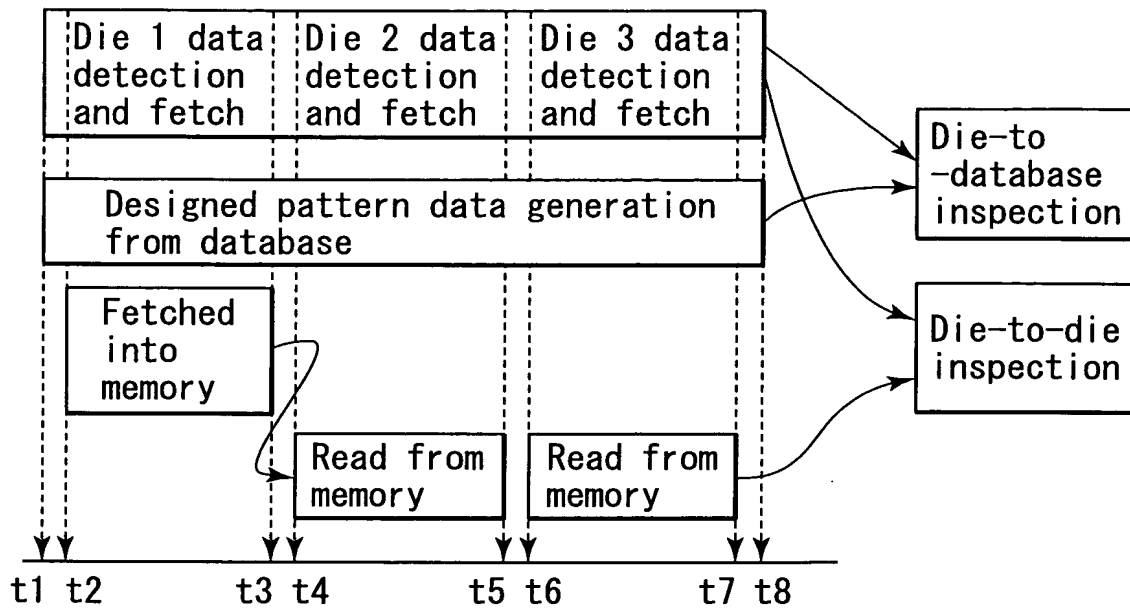


FIG. 8

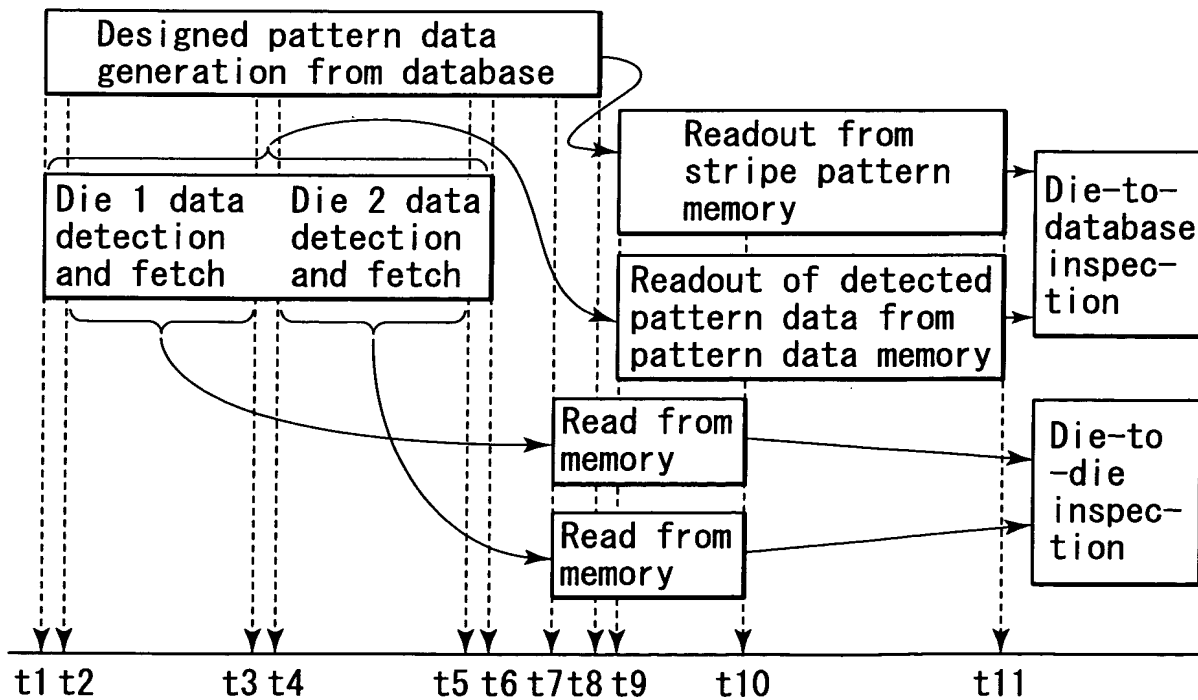


FIG. 9

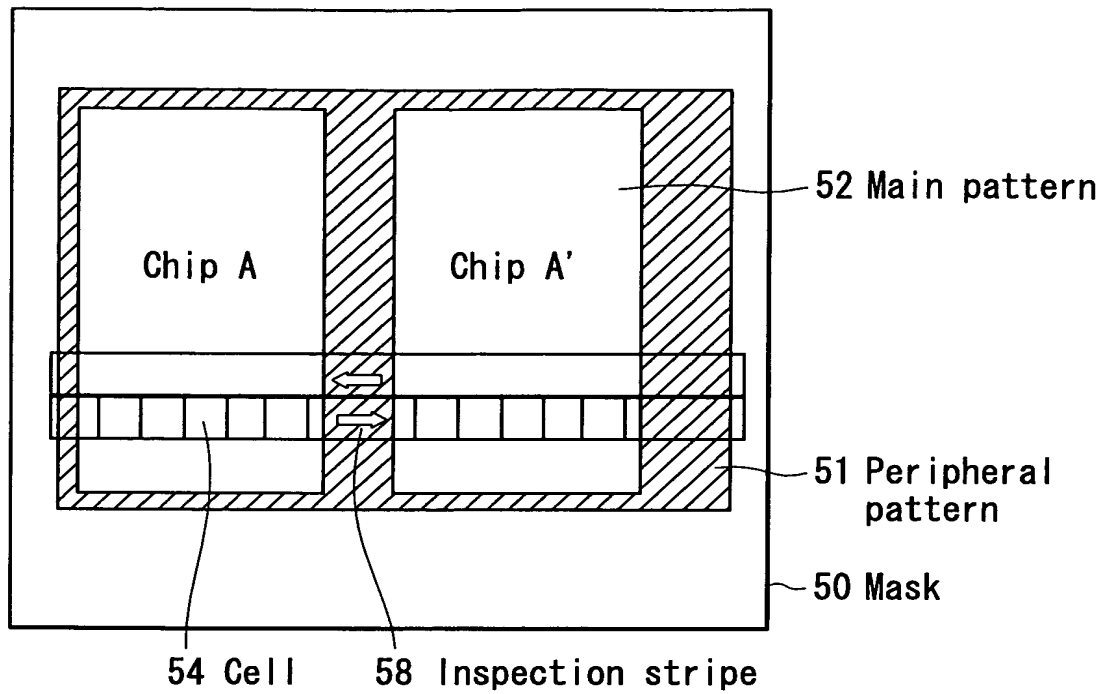


FIG. 10

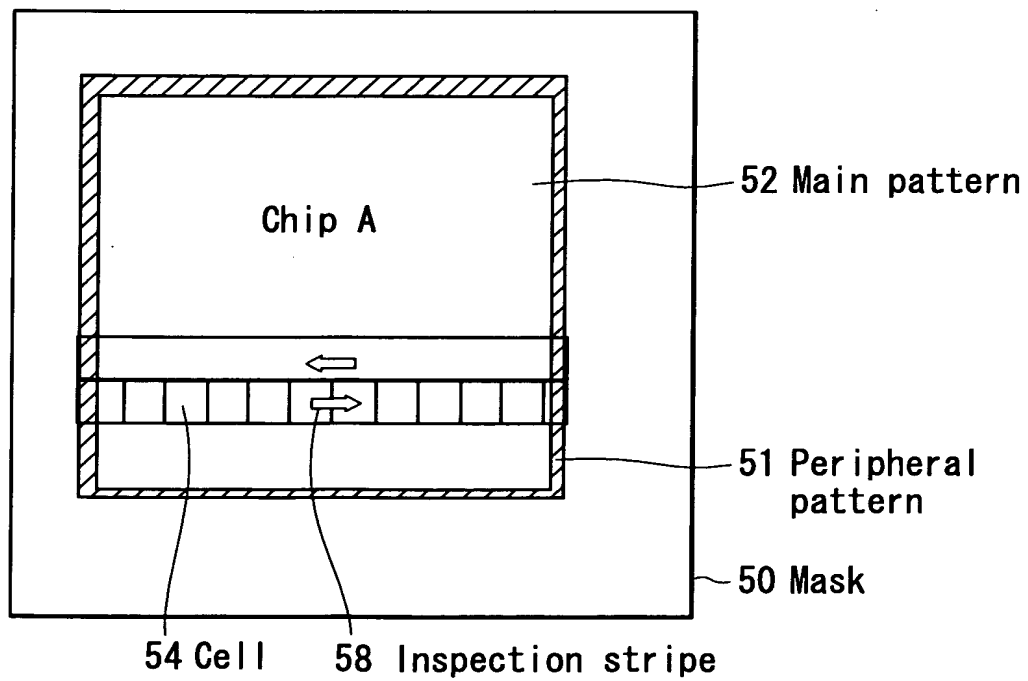


FIG. 11

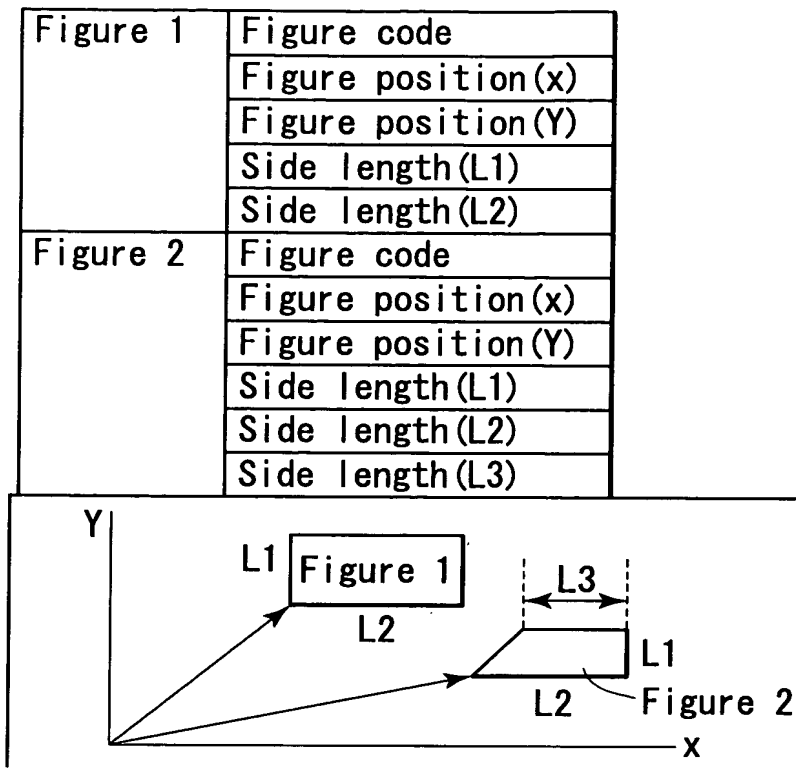


FIG. 12

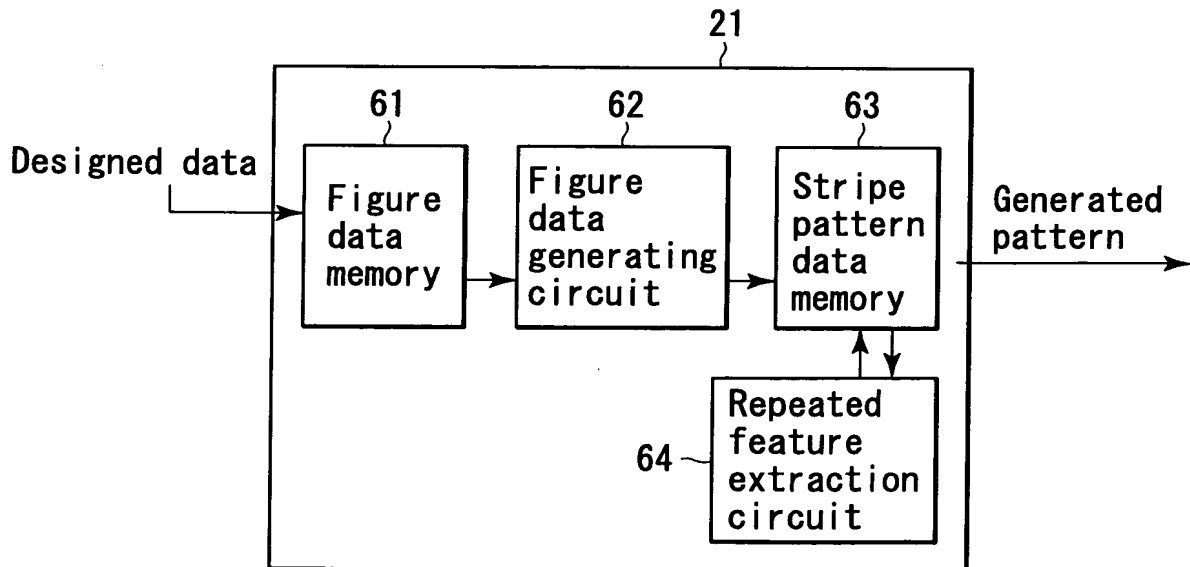


FIG. 13

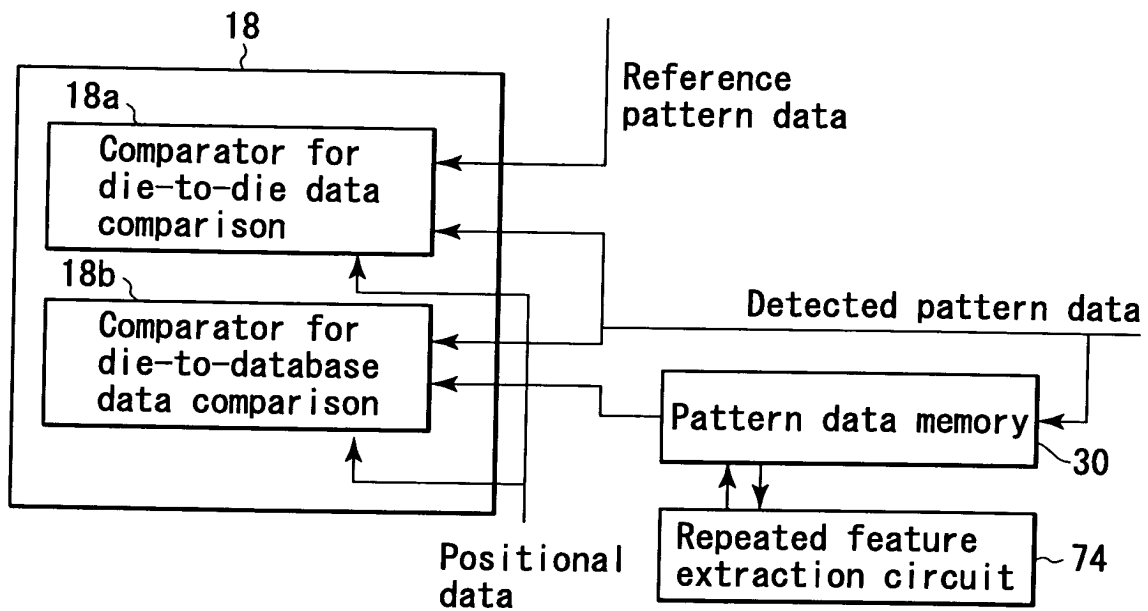


FIG. 14

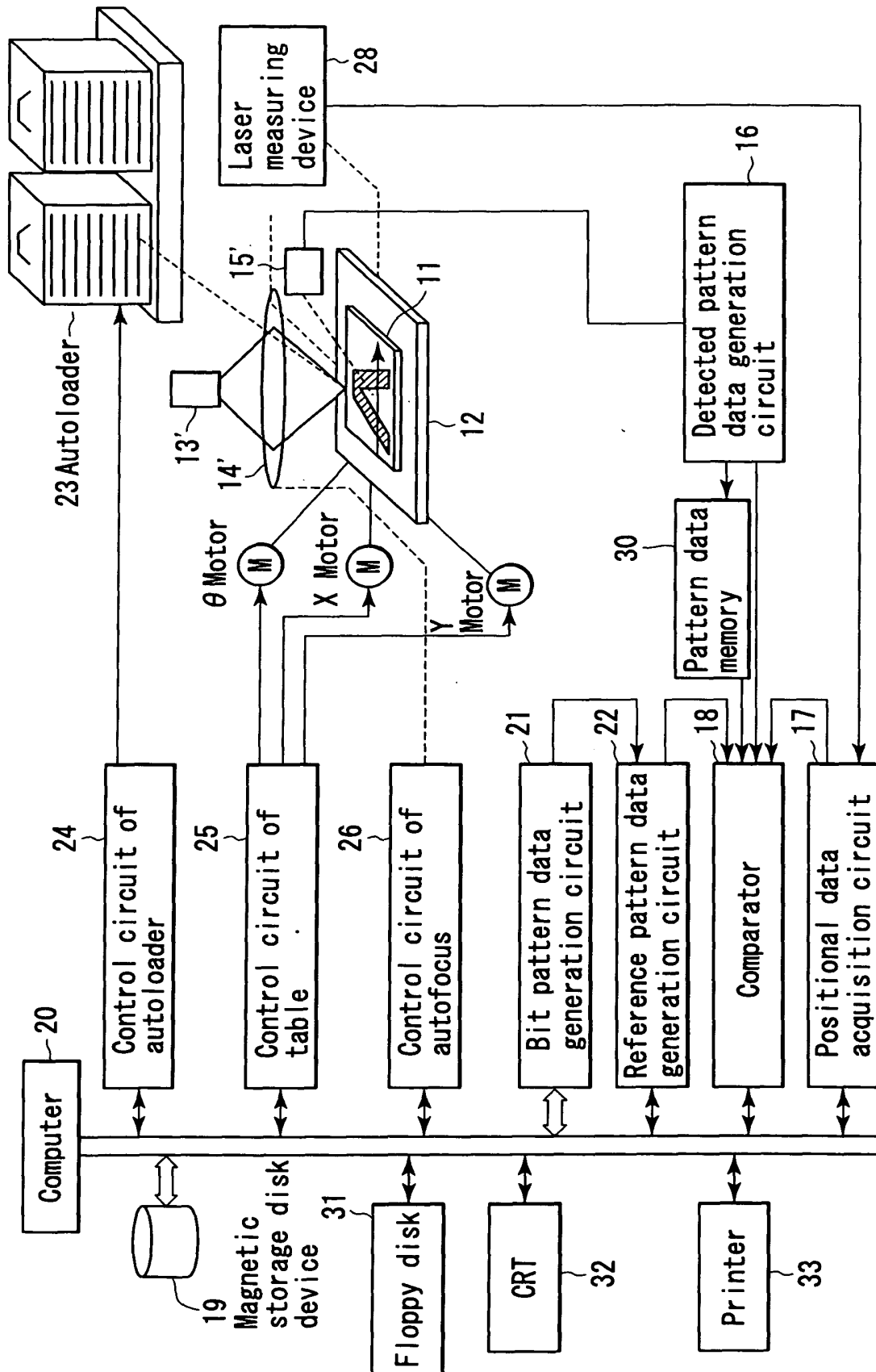


FIG. 15